



74BCT827B

10-Bit Buffer/Line Driver with TRI-STATE® Outputs

General Description

The 'BCT827B 10-bit buffer and line driver provides high performance bus interface buffering for wide data/address paths or buses carrying parity. This device is designed to be employed as a memory and address driver, clock driver, or bus-oriented transmitter/receiver.

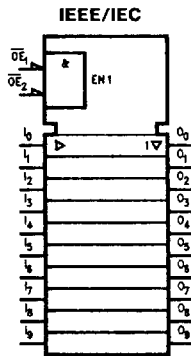
The 'BCT827B is a functional and pin compatible replacement for the TI 'BCT29827B.

Features

- Non-inverting buffers
- TRI-STATE outputs drive bus lines or buffer memory address registers
- Low I_{CCZ} through BiCMOS techniques
- Guaranteed output skew
- Guaranteed multiple output switching specifications
- Guaranteed 4000V minimum ESD protection
- Guaranteed latchup protection
- Nondestructive hot insertion capability
- High impedance in power down (I_{ZZ} and V_{IP})

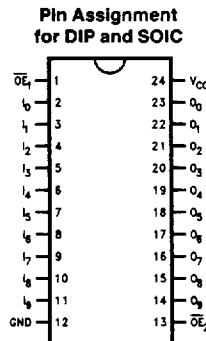
Ordering Code: See Section 11

Logic Symbol



TL/F/10918-1

Connection Diagram



TL/F/10918-2

Truth Table

OE _n	I _n	O _n
L	H	H
L	L	L
H	X	Z

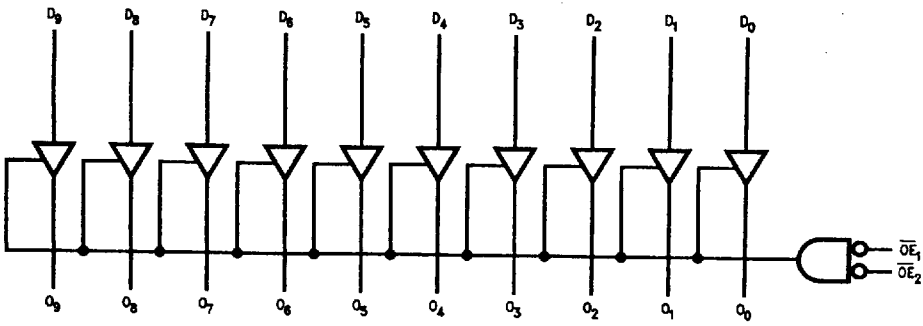
H = HIGH Voltage Level
L = LOW Voltage Level

X = Immaterial
Z = High Impedance

Pin Names	Description
OE ₁ , OE ₂	Output Enable Input (Active LOW)
I ₀ -I ₇	Inputs
O ₀ -O ₇	Outputs

Logic Diagram

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Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature	-65°C to +150°C
Ambient Temperature Under Bias	-55°C to +125°C
Junction Temperature Under Bias Plastic	-55°C to +150°C
V _{CC} Pin Potential to Ground Pin	-0.5V to +7.0V
Input Voltage (Note 2)	-0.5V to +7.0V
Input Current (Note 2)	-30 mA to +5.0 mA
Voltage Applied to Any Output in the Disable or Power-Off State in the High State	-0.5V to +5.5V -0.5V to V _{CC}

Current Applied to Output in LOW State (Max)	Twice the Rated I _{OL} (mA)
ESD Last Passing Voltage (Min)	4000V
DC Latchup Source Current	500 mA
Over Voltage Latchup	V _{CC} + 4.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature Commercial	0°C to +70°C
Supply Voltage Commercial	+4.5V to +5.5V

DC Electrical Characteristics

Symbol	Parameter	74BCT			Units	V _{CC}	Conditions
		Min	Typ	Max			
V _{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH Voltage	2.4 2.0			V	Min	I _{OH} = -3 mA I _{OH} = -24 mA
V _{OL}	Output LOW Voltage			0.55	V	Min	I _{OL} = 64 mA
I _{IH}	Input HIGH Current			5	μA	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdown Test			7	μA	Max	V _{IN} = 7.0V
I _{IL}	Input LOW Current			-200	μA	Max	V _{IN} = 0.5V
I _{OS}	Output Short-Circuit Current	-100		-250	mA	Max	V _{OUT} = 0V
I _{OZH}	Output Leakage Current			20	μA	Max	V _{OUT} = 2.7V
I _{OZL}	Output Leakage Current			-20	μA	Max	V _{OUT} = 0.5V
I _{CEX}	Output HIGH Leakage Current			50	μA	Max	V _{OUT} = V _{CC}
V _{ID}	Input Leakage Test	4.75			V	0.0	I _{ID} = 1.9 μA All Other Pins Grounded
I _{ZZ}	Bus Drainage Test			100	μA	0.0	V _{OUT} = 5.25V
I _{CCH}	Power Supply Current		10.8	15	mA	Max	V _O = HIGH
I _{CCL}	Power Supply Current		33.4	40	mA	Max	V _O = LOW
I _{CCZ}	Power Supply Current		4	6	mA	Max	V _O = HIGH Z

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AC Electrical Characteristics: See Section 8 for Waveforms and Load Configurations

Symbol	Parameter	74BCT			74BCT		Units	Fig. No.
		T _A = +25°C V _{CC} = +5.0V C _L = 50 pF			T _A = Com V _{CC} = Com C _L = 50 pF			
		Min	Typ	Max	Min	Max		
t _{PLH} t _{PHL}	Propagation Delay Data to Output	1.0 2.0	2.7 4.6	5.3 7.3	1.0 1.5	5.5 7.5	ns	8-3
t _{PZH} t _{PZL}	Output Enable Time	4.0 4.0	8.4 7.1	11.0 11.0	4.0 4.0	12.0 12.0	ns	8-5
t _{PHZ} t _{PLZ}	Output Disable Time	1.0 1.0	4.3 5.0	7.6 7.6	1.0 1.0	8.4 8.4	ns	8-5
t _{OSSL} (Note 1)	Pin to Pin Skew HL Data to Output			0.8		0.8	ns	
t _{OSLH} (Note 1)	Pin to Pin Skew LH Data to Output			0.7		1.0	ns	
t _{OST} (Note 1)	Pin to Pin Skew LH/HL Data to Output			4.0		6.0	ns	
t _{py} (Note 2)	Device to Device Skew LH/HL Data to Output			4.0		5.0	ns	

Note 1: Skew is defined as the absolute value of the difference between the actual propagation delays for any two separate outputs of the same device. The specification applies to any outputs switching HIGH to LOW (t_{OSSL}), LOW to HIGH (t_{OSLH}), or any combination switching LOW to HIGH and/or HIGH to LOW (t_{OST}). This specification is guaranteed but not tested.

Note 2: Propagation delay variation for a given set of conditions (i.e., temperature and V_{CC}) from device to device. This specification is guaranteed but not tested.

Extended AC Electrical Characteristics: See Section 8 for Waveforms and Load Configurations

Symbol	Parameter	74BCT		74BCT		Units	Fig. No.
		T _A = Com V _{CC} = Com C _L = 50 pF 8 Outputs Switching (Note 1)		T _A = Com V _{CC} = Com C _L = 250 pF (Note 2)			
		Min	Max	Min	Max		
t _{PLH} t _{PHL}	Propagation Delay Data to Output	2.0 4.0	6.5 9.5	3.5 4.5	7.5 9.5	ns	8-3

Note 1: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase (i.e., all low-to-high, high-to-low, etc.)

Note 2: This specification is guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load.

Capacitance

Symbol	Parameter	Typ	Units	Conditions
C _{IN}	Input Capacitance	6.0	pF	V _{CC} = 5.0V
C _{OUT}	Output Pin Capacitance	15.0	pF	V _{CC} = 5.0V

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